TOSHIBA CCD Linear Image Sensor CCD (Charge Coupled Device)

# TCD1710DG

The TCD1710DG is a high sensitive and low dark current 7500 elements x 2 lines CCD image sensor.

The sensor is designed for facsimile, image scanner and OCR. The device contains a row of 7500 elements photodiodes which provide a 24 lines/mm (600DPI) across a A3 size paper. The device is operated by 5 V (pulse), and 5 V power supply.

## Features

- Number of Image Sensing Elements: 7500 elements x 2 lines
- Image sensing element size: 4.7 µm by 4.7 µm on 4.7 µm centers
- Photo sensing region: High sensitive and low voltage dark signal pn photodiode
- Distance Between Photodiode Array: 47  $\mu\text{m},$  10 lines
- Clock: 2 phase (5 V)
- Power Supply: 5V Power Supply Voltage
- Package: 22 pin Cerdip

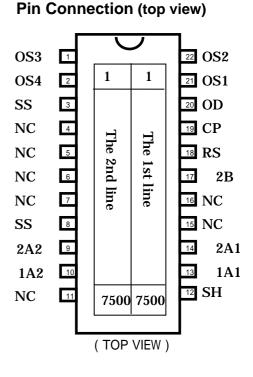
# Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Clock pulse voltage	$V_{\phi}$		V
Shift pulse voltage	V <sub>SH</sub>	–0.3 to 7	
Reset pulse voltage	V <sub>RS</sub>	-0.0 10 7	
Clamp pulse voltage	V <sub>CP</sub>		
Power supply voltage	V <sub>OD</sub>	–0.3 to 7	
Operating temperature	T <sub>opr</sub>	0 to 60	°C
Storage temperature	T <sub>stg</sub>	–25 to 85	°C

Note 1: All voltage are with respect to SS terminals (ground).

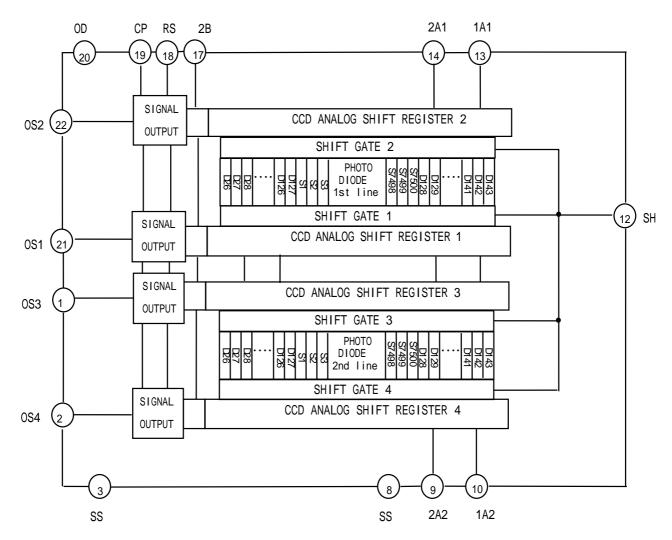
# ИПР22-G-400-2.54D

#### Weight: 4.4 g (typ.)



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# **Circuit Diagram**



### **Pin Names**

φ1A	Clock (Phase 1)
φ2A	Clock (Phase 2)
φ2B	Final stage clock (Phase 2)
SH	Shift gate
RS	Reset gate
CP	Clamp gate
OS	Signal output
OD	Power
SS	Ground
NC	Non connection

# <u>TOSHIBA</u>

## **Optical/Electrical Characteristics**

 $(Ta = 25^{\circ}C, V_{OD} = 5 V, V_{\phi} = V_{SH} = V_{RS} = V_{CP} = 5 V$  (Pulse),  $f_{\phi} = 1 MHz$ ,  $t_{INT}$  (Integration Time) = 10 ms, Light Source = Daylight Fluorescent Lamp, LOAD Resistance = 100 k $\Omega$ )

Characteristics	Symbol	Min	Тур.	Max	Unit	Note
Sensitivity	R	12	15	18	V/lx·s	
Photo response non uniformity	PRNU	_	4	10	%	(Note 2)
	PRNU (3)	_	6	12	mV	(Note 8)
Saturation output voltage	V <sub>SAT</sub>	1.0	1.3	_	V	(Note 3)
Saturation exposure	SE	0.05	0.08	—	lx∙s	(Note 4)
Dark signal voltage	V <sub>DRK</sub>	_	1.0	3	mV	(Note 5)
Dark signal non uniformity	DSNU	_	4.0	10	mV	(Note 5)
DC power dissipation	PD	_	100	150	mW	
Total transfer efficiency	TTE	92	98	_	%	
Output impedance	Zo	_	0.2	0.5	kΩ	
Dynamic range	DR	_	1300	_	_	(Note 6)
DC signal output voltage	V <sub>OS</sub>	2.0	2.5	3.5	V	(Note 7)
DC differential error voltage	V <sub>OSX</sub> – V <sub>OSY</sub>	_		300	mV	(Note 9)
Random noise	NDσ	_	1.0	—	mV	(Note 10)

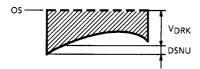
Note 2: Measured at 50% of SE (typ.)

Definition of PRNU: PRNU =  $\frac{\Delta \chi}{\overline{\chi}} \times 100(\%)$ 

Where  $\overline{\chi}$  is average of total signal outputs and  $\Delta \chi$  is maximum deviation from  $\overline{\chi}$  under uniform illumination. (Channel 1)

In the case of 3750 elements (Channel 2,3,4), the condition is the same as above too.

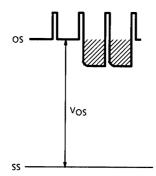
- Note 3:  $V_{SAT}$  is defined as minimum saturation output voltage of all effective pixels.
- Note 4: Definition of SE: SE =  $\frac{V_{SAT}}{R}$  (lx·s)
- Note 5: V<sub>DRK</sub> is defined as average dark signal voltage of all effective pixels. DSNU is defined as different voltage between V<sub>DRK</sub> and V<sub>MDK</sub> when V<sub>MDK</sub> is maximum dark signal voltage.



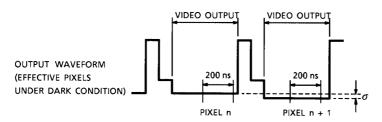
Note 6: Definition of DR: DR =  $\frac{V_{SAT}}{V_{DRK}}$ 

 $V_{DRK}$  is proportional to  $t_{INT}$  (Integration Time). So the shorter  $t_{INT}$  condition makes wider DR values.

Note 7: DC signal output voltage and DC compensation output voltage are defined as follows:



- Note 8: PRNU (3) is defined as maximum voltage with next pixel, where measured 5% of SE (typ.)
- Note 9: DC differential error voltage is defined as follows : Definition of DC differential error voltage =  $|V_{OSX} - V_{OSY}|$  $V_{OSX}$ : Maximum DC signal output voltage  $V_{OSY}$ : Minimum DC signal output voltage
- Note 10: Random noise is defined as the standard deviation (sigma) of the output level difference between two adjacent effective pixels under no illumination (i.e. dark condition) calculated by the following procedure.



- 1) Two adjacent pixels (pixel n and n + 1) in one reading are fixed as measurement points.
- Each of the output levels at video output periods averaged over 200 nanosecond period to get Vn and Vn + 1.
- 3) Vn + 1 is subtracted from Vn to get  $\Delta V$ .  $\Delta V = Vn - Vn + 1$
- The standard deviation of ∆V is calculated after procedure 2) and 3) are repeated 30 times (30 readings).

$$\overline{\Delta V} = \frac{1}{30} \sum_{i=1}^{30} |\Delta V_i| \qquad \qquad \sigma = \sqrt{\frac{1}{30} \sum_{i=1}^{30} (|\Delta V_i| - \overline{\Delta V})^2}$$

5) Procedure 2), 3) and 4) are repeated 10 times to get 10 sigma values.

$$\overline{\sigma} = \frac{1}{10} \sum_{j=1}^{10} \sigma j$$

6)  $\overline{\sigma}$  value calculated using the above procedure is observed  $\sqrt{2}$  times larger than that measured relative to the ground level. So we specify the random noise as follows.

Random noise = 
$$\frac{1}{\sqrt{2}}\overline{\sigma}$$

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# **Operating Condition**

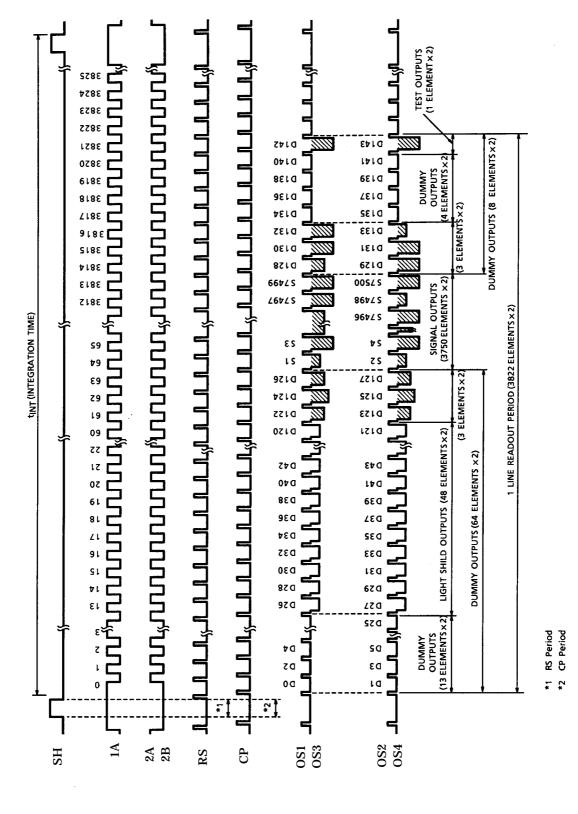
Characteristics		Symbol	Min	Тур.	Max	Unit
Clock pulse voltage	"H" Level	Vø1A	4.75	5	5.25	V
Clock pulse voltage	"L" Level	V¢2A	0	_	0.25	V
Final stage clock voltage	"H" Level	V∳2B	4.75	5	5.25	v
T mai stage clock voltage	"L" Level	V	0	_	0.25	v
Shift pulse voltage	"H" Level	V <sub>SH</sub>	VøA"H"-0.25	V¢A"H"	V¢A"H"	v
(Note11)	"L" Level	۷SH	0	_	0.25	v
Reset pulse voltage	"H" Level	V <sub>RS</sub>	4.75	5	5.25	v
	"L" Level	VRS	0		0.25	v
Clamp pulse voltage	"H" Level	V <sub>CP</sub>	4.75	5	5.25	V
Clamp pulse vollage	"L" Level	vСР	0	_	0.25	v
Power supply voltage		V <sub>OD</sub>	4.75	5.0	5.25	V

Note 11:  $V\phi A$ "H" means the value of high level voltage at  $V\phi A$  when SH pulse is high level.

# **Clock Characteristics (Ta = 25°C)**

Characteristics	Symbol	Min	Тур.	Max	Unit
Clock pulse frequency	$f_{\varphi}$	0.5	1	15	MHz
Reset pulse frequency	f <sub>RS</sub>	0.5	1	15	MHz
Clock capacitance (Note 12)	CộA	_	400	_	pF
Final stage clock capacitance	СфВ	_	20	_	pF
Shift gate capacitance	C <sub>SH</sub>	_	500	_	pF
Reset gate capacitance	C <sub>RS</sub>	_	20	_	pF
Clamp gate capacitance	C <sub>CP</sub>	_	20	_	pF

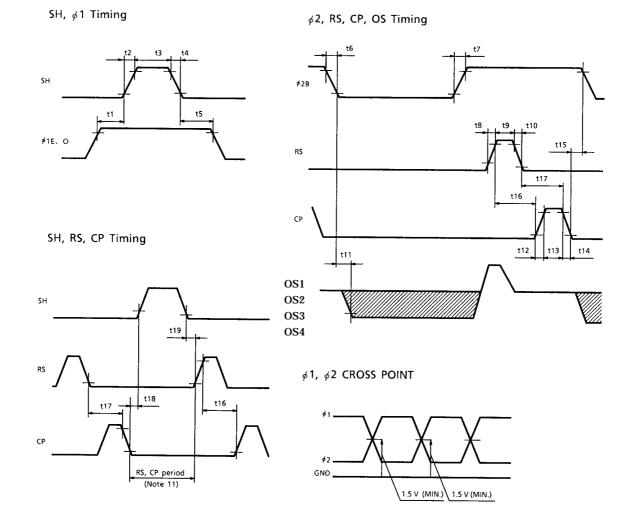
Note 12:  $V_{OD} = 5 V$ 



**Timing Chart** 

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# **Timing Requirements**



Note 11: Each RS and CP pins put to Low level during this period.

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Characteristics	Symbol	Min	Typ. (Note 12)	Max	Unit
Pulse timing of SH and $\phi 1A$	t1, t5,	200	500	_	ns
SH pulse rise time, fall time	t2, t4	0	50	_	ns
SH pulse width	t3	1000	1500	5000	ns
$\phi$ 2B pulse rise time, fall time	t6, t7	0	20	_	ns
RS pulse rise time, fall time	t8, t10	0	20	_	ns
RS pulse width	t9	10	100	_	ns
Video data delay time (Note 13)	t11	_	20	_	ns
CP pulse rise time, fall time	t12, t14	0	20	_	ns
CP pulse width	t13	10	200	_	ns
Pulse timing of $\phi$ 2B and CP	t15	0	50	_	ns
Pulse timing of RS and CP	t16	0	0	_	
	t17	10	100	_	ns
Pulse timing of SH and CP	t18	200	_	_	ns
Pulse timing of SH and RS	t19	200	_	—	ns

Note 12: Typ. is the case of  $f_{RS}=1.0\ \text{MHz}$ 

Note 13: Load resistance is 100  $\text{k}\Omega$ 

## Caution

#### 1. Window Glass

The dust and stain on the glass window of the package degrade optical performance of CCD sensor. Keep the glass window clean by saturating a cotton swab in alcohol and lightly wiping the surface, and allow the glass to dry, by blowing with filtered dry N2. Care should be taken to avoid mechanical or thermal shock because the glass window is easily to damage.

## 2. Electrostatic Breakdown

Store in shorting clip or in conductive foam to avoid electrostatic breakdown.

CCD Image Sensor is protected against static electricity, but interior puncture mode device due to static electricity is sometimes detected. In handing the device, it is necessary to execute the following static electricity preventive measures, in order to prevent the trouble rate increase of the manufacturing system due to static electricity.

- a. Prevent the generation of static electricity due to friction by making the work with bare hands or by putting on cotton gloves and non-charging working clothes.
- b. Discharge the static electricity by providing earth plate or earth wire on the floor, door or stand of the work room.
- Ground the tools such as soldering iron, radio cutting pliers of or pincer.
   It is not necessarily required to execute all precaution items for static electricity.

It is all right to mitigate the precautions by confirming that the trouble rate within the prescribed range.

#### 3. Incident Light

CCD sensor is sensitive to infrared light. Note that infrared light component degrades resolution and PRNU of CCD sensor.

#### 4. Lead Frame Forming

Since this package is not strong against mechanical stress, you should not reform the lead frame. We recommend to use a IC-inserter when you assemble to PCB.

#### 5. Soldering

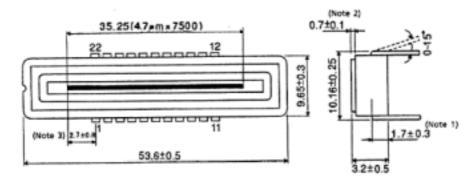
Soldering by the solder flow method cannot be guaranteed because this method may have deleterious effects on prevention of window glass soiling and heat resistance.

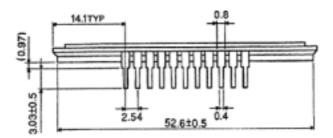
Using a soldering iron, complete soldering within ten seconds for lead temperatures of up to 260°C, or within three seconds for lead temperatures of up to 350°C.

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# PACKAGE DIMENSIONS

Unit : mm





Note 1: TOP OF CHIP TO BOTTOM OF PACKAGE

Note 2: GLASS THICKNESS (n = 1.5)

Note 3: No.1 SENSOR ELEMENT (S1) TO CENTER OF No.1 PIN.

Weight : 4.4 g (typ.)

About solderability, following conditions were confirmed
Solderability
<ul> <li>(1) Use of Sn-63Pb solder Bath <ul> <li>solder bath temperature = 230°C</li> <li>dipping time = 5 seconds</li> <li>the number of times = once</li> <li>use of R-type flux</li> </ul> </li> </ul>
<ul> <li>(2) Use of Sn-3.0Ag-0.5Cu solder Bath <ul> <li>solder bath temperature = 245°C</li> <li>dipping time = 5 seconds</li> <li>the number of times = once</li> <li>use of R-type flux</li> </ul> </li> </ul>

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